

<b>Notice of References Cited</b>	Application/Control No. 10/760,345	Applicant(s)/Patent Under Reexamination CHIN ET AL.	
	Examiner Andrew M. Deschere	Art Unit 2836	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,782,491	08-2004	Foedlmeier et al.	714/37
*	B	US-5,890,780	04-1999	Tomiyori, Yutaka	307/86
*	C	US-6,357,011	03-2002	Gilbert, Timothy G.	713/300
*	D	US-6,199,168	03-2001	Miller, Bruce	713/300
*	E	US-5,721,481	02-1998	Narita et al.	320/111
*	F	US-2004/0164708	08-2004	Veselic et al.	320/132
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.